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Layered Structures and Epitaxy

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Layered Structures and Epitaxy

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Preface

This book contains written accounts of almost all papers presented during the Symposium on Layered Structures and Epitaxy, held during the Meeting of the Materials Research Society in Boston, December, 1-6, 1985. The Symposium covered new developments in epitaxial growth, superlattices, quantum wells and (amorphous) layered systems. The organizers thank all authors for their invaluable contributions which made this symposium a successful enterprise.

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J.M. Gibson
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PART I

**Epitaxial Growth
of Semiconductors**

